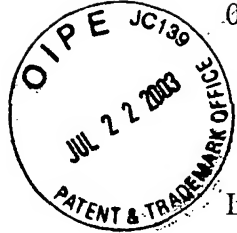


.03560.003310

PATENT APPLICATION



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

'In re Application of:

TADASHI OKAMOTO ET AL.

Application No.: 10/601,777

Filed: June 24, 2003

For: A METHOD FOR ACQUIRING  
INFORMATION OF A BIOCHIP  
USING TIME OF FLIGHT  
SECONDARY ION MASS  
SPECTROMETRY AND AN  
APPARATUS FOR ACQUIRING  
INFORMATION FOR THE  
APPLICATION THEREOF

Examiner: Not Yet Assigned

Group Art Unit: Not Yet Assigned

July 21, 2003

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. Copies of the listed documents are also enclosed.

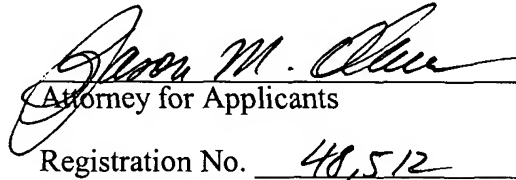
The concise explanation of relevance for the non-English documents may be found, inter alia, in the specification where they are cited and/or in the English language abstracts attached thereto. In addition, the concise explanation of relevance for JP11-187900 may be found in corresponding U.S. Patent No. 6,476,215 B1.

CONCLUSION

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicants' undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

Respectfully submitted,

  
\_\_\_\_\_  
Attorney for Applicants  
Registration No. 48,512

FITZPATRICK, CELLA, HARPER & SCINTO  
30 Rockefeller Plaza  
New York, New York 10112-3801  
Facsimile: (212) 218-2200

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)		ATTY DOCKET NO. <b>03560.003310</b>		APPLICATION NO. <b>10/601,777</b>	
		APPLICANT <b>Tadashi Okamoto et al.</b>			
		FILING DATE <b>Jun 24, 2003</b>		GROUP <b>N.Y.A.</b>	

U.S. PATENT DOCUMENTS							
*	EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		5,405,783	04/11/95	Pirrung et al.	436	518	
		5,601,980	02/11/97	Gordon et al.	435	6	
		6,384,237 B1	05/07/02	Suzuki et al.	549	13	
		6,476,215 B1	11/05/02	Okamoto et al.	536	25.3	

FOREIGN PATENT DOCUMENTS							
*	EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
		11-187900	07/13/99	Japan			Abstract

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)	
	Mark Schena et al., "Quantitative Monitoring of Gene Expression Patterns with a Complementary DNA Microarray," 270 <u>Science</u> 467-470 (October 1995).
	H.F. Arlinghaus et al., "TOF-SIMS Characterization of DNA and PNA Biosensor Chips," Proceedings of the 12 <sup>th</sup> International Conference on Secondary Ion Mass Spectrometry, pp. 951-954 (September 1999).

EXAMINER	DATE CONSIDERED
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.